



Optical Link of the ATLAS Pixel Detector

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October 6, 2005

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Outline



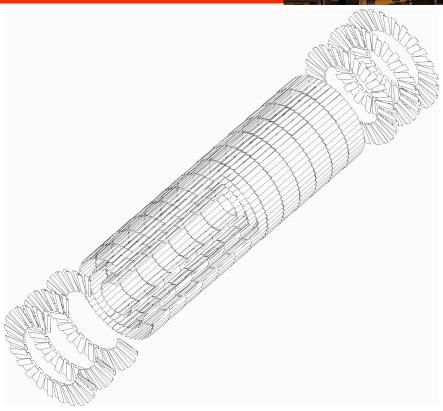
- Introduction
- Proton Irradiation Studies
- Production Status
- Summary



ATLAS Pixel Detector



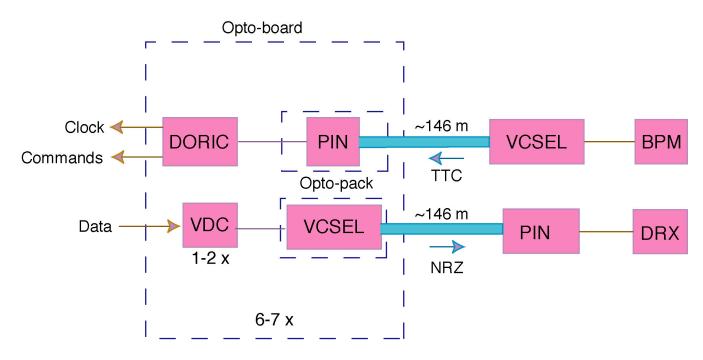
- Inner most tracking detector
- Pixel size: 50 μm x 400 μm
- 100 million channels
- Barrel layers at r = 5.1-12.3 cm
- Disks at z = 50-65 cm
- Dosage after 10 years:
 - optical link: 17 Mrad or 3.7 x 10^{14} 1-MeV n_{eq}/cm^2





ATLAS Pixel Opto-link





VCSEL: Vertical Cavity Surface Emitting Laser diode

VDC: VCSEL Driver Circuit

PIN: PiN diode

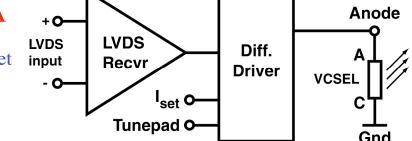
DORIC: Digital Optical Receiver Integrated Circuit



VDC: VCSEL Driver Circuit



- Convert LVDS input signal into single-ended signal appropriate to drive VCSEL diode
- Output (bright) current: 0 to 20 mA
 - controlled by external current I_{set}



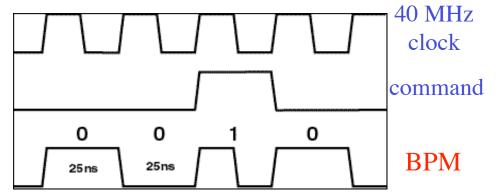
- Standing (dim) current: ~ 1 mA
 - improve switching speed
- Rise & fall times: 1 ns nominal for 40 MHz signals
- "On" voltage of VCSEL: up to 2.3 V at 20 mA for 2.5 V supply
- Constant current consumption!
- Use IBM 0.25 μm CMOS
- Use Truelight high-power oxide common cathode VCSEL array
 K.K. Gan

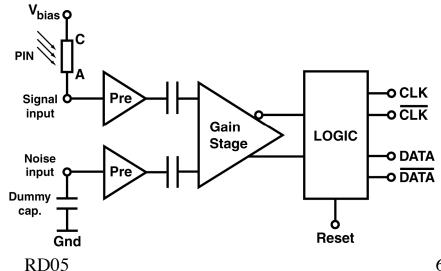


DORIC: Digital Optical Receiver IC



- Decode Bi-Phase Mark encoded (BPM) clock and command signals from PIN diode
- Input signal: 40-1000 µA
- Extract: 40 MHz clock
- Duty cycle: $(50 \pm 4)\%$
- Total timing error: < 1 ns
- Bit Error Rate (BER): < 10⁻¹¹ at end of life
- Use IBM 0.25 µm CMOS
- Use Truelight common cathode PIN array (Taiwan)







Status of BeO Opto-board



- converts: optical signal ↔ electrical signal
- contains 7 optical links
- use BeO for heat management but prototype initially in FR-4 for fast turnaround and cost saving
- 1st BeO vendor:
 - either under or over filling of vias
 - ⇒ use more experienced/expensive vendor
- 2nd BeO vendor:
 - ◆ 1st prototype: 1-2 SMD detached from few boards
 - remove gold under SMD pads
 - ◆ 2nd prototype: SMD pads have much better adhesion
 - remove gold under 80-pin connector pads
 - ⇒ order production opto-boards



BeO Opto-board

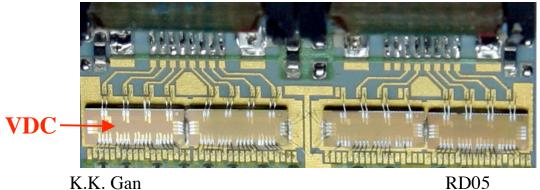


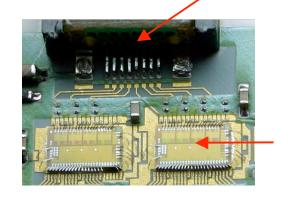
VCSEL opto-pack

housing



PIN opto-pack



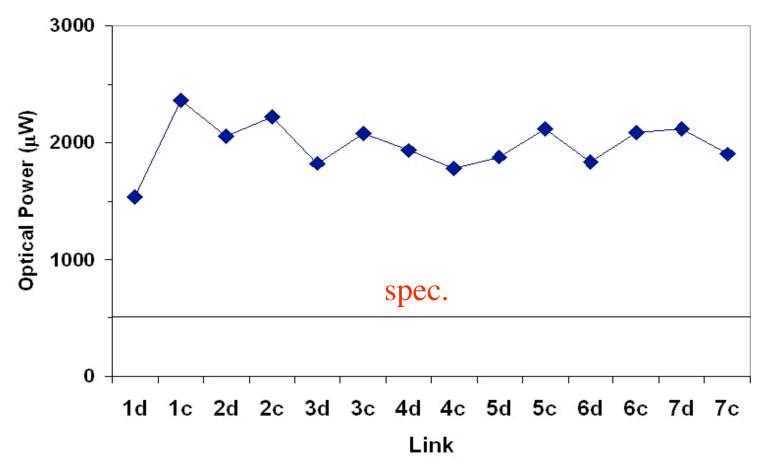


DORIC



Optical Power



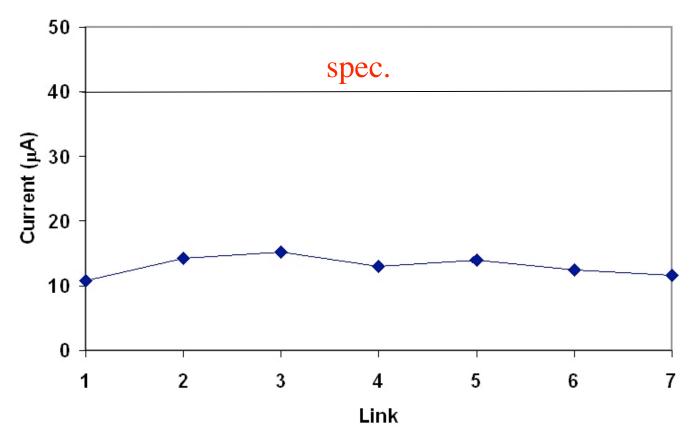


• optical power at 10 mA significantly above spec, 500 μW



Minimum PIN Current for No Bit Errors



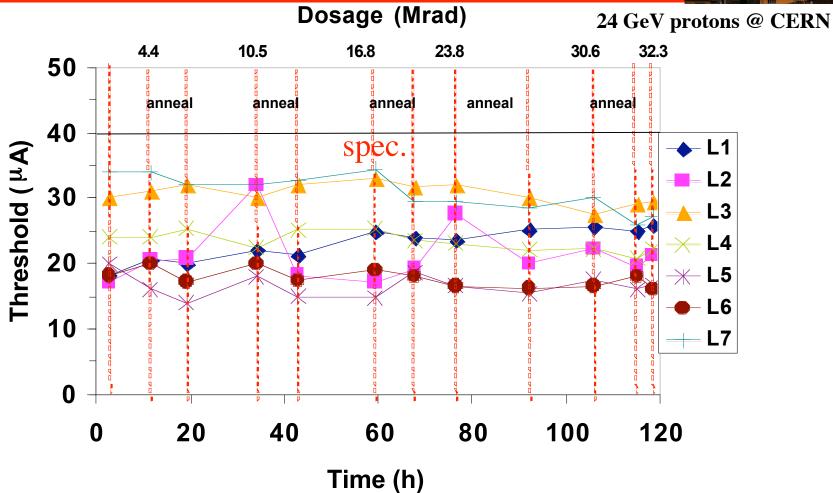


• minimum PIN current for no bit errors with all links active significantly below spec, 40 μA



PIN Current Threshold vs Dosage





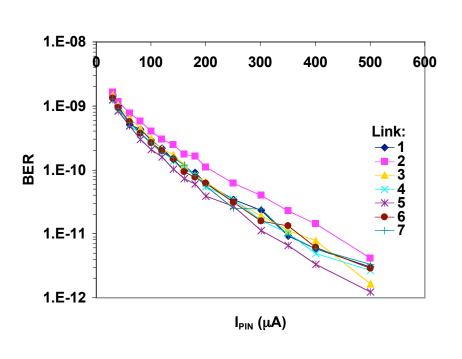
• PIN current thresholds for no bit errors remain constant

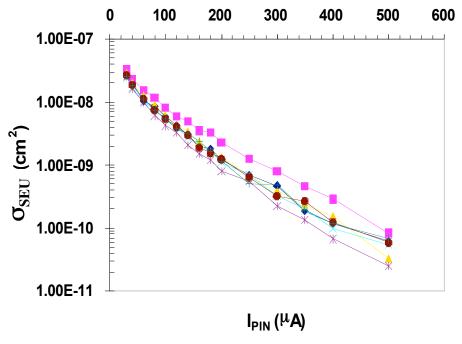


Proton Induced Bit Errors in PIN



• convert observed bit errors into bit error rate at opto-link location:



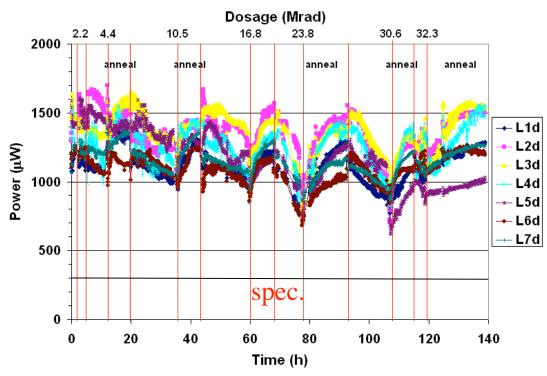


- bit error rate decreases with PIN current as expected
- bit error rate $\sim 3 \times 10^{-10}$ at 100 μ A (1.4 errors/minute)
 - DORIC spec: 10⁻¹¹



Optical Power vs Dosage





- irradiation procedure: ~ 5 Mrad/day (10 hours) with annealing rest of the day
- optical power decreases with dosage as expected
- limited annealing recovers some lost power
- still have good optical power after 30 Mrad K.K. Gan



Opto-Production Challenges



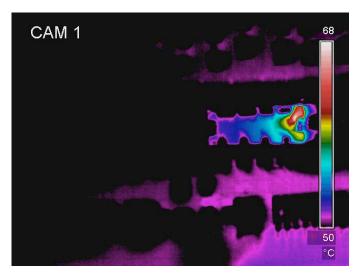
- rigorous QA procedure:
 - ◆ 72 hours of burn-in at 50°C
 - ◆ 18 hours of 10 thermal cycles between -25°C and 50°C
 - 8 hours of optical and electrical measurements
- use 2 ovens and 2 environmental chambers
- implemented an "early shift" to extend the work day
- aggressive goals:
 - producing 10 boards/week
 - complete production by early October



Initial Production Problem



- initial plan was not to test chips before mounting on opto-board due to high yield during pre-production
- a bunch of produced boards drawing excessive currents
 - thermal image: power to ground shorts
- ⇒ test chips before mounting



VDC



DORIC



Opto-board Rework



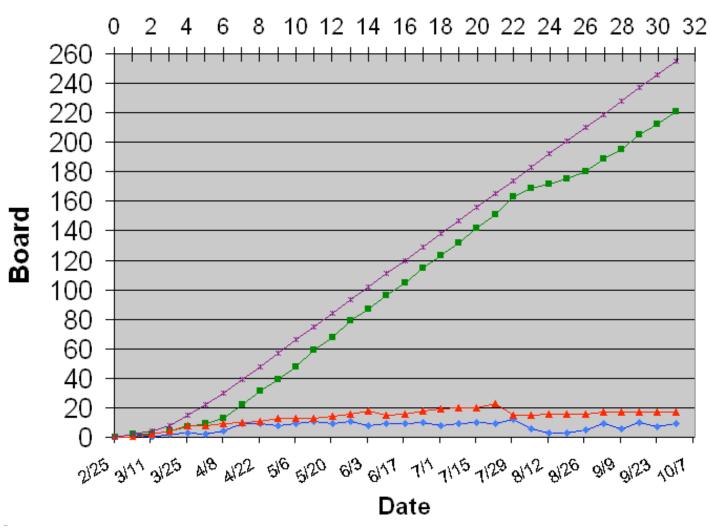
- recover opto-boards by stacking new chips on top of bad chips
- reworked opto-boards must pass same rigorous QA procedure
 - classified as second class for use as spare
- 18 opto-boards have been recovered



Opto-board Production Status









Summary



- opto-boards of ATLAS pixel detector satisfy design spec. and radiation hardness requirement:
 - ✓ low PIN current thresholds for no bit errors
 - excellent optical power
 - ✓ radiation hard up to ~ 30 Mrad
- simple and modular design allows smooth production
 - production expected to complete this week